Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/643,974	MEI ET AL.	
Examiner	Art Unit	
Cynthia Lee	1745	

	SEARCHED			
Class	Subclass	Date	Examiner	
429	40	7/5/2006	CL	
502	200, 313	7/5/2006	CL	
502	315-317	7/5/2006	CL	
502	326, 330	7/5/2006	CL	
502	337-339	7/5/2006	CL	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
inventor search	7/5/2006	CL
IDS	7/5/2006	CL
consulted outside searches (class 502) with Patricia Hailey (1755)	7/6/2006	CL
STN chemical search	7/5/2006	CL
STIC chemical search	7/5/2006	CL
EAST search	7/6/2006	CL